


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595332	<b>Applicant(s)/Patent Under Reexamination</b>  DENNERT ET AL.
	<b>Examiner</b>  QUN SHEN	<b>Art Unit</b>  4153

SEARCHED			
Class	Subclass	Date	Examiner
455	417	12/3/2010	Qun Shen
455	445	12/3/2010	Qun Shen
455	509	12/3/2010	Qun Shen

SEARCH NOTES		
Search Notes	Date	Examiner
Text search on East	12/2/2010	Qun Shen
Text search on Google Patent	6/1/2010	Qun Shen
Text search on Google Scholar	6/3/09	Qun Shen
International Search Report	6/3/09	Qun Shen
Inventor search	12/12/09	Qun Shen

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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